



# STS26N3LLH6

N-channel 30 V, 0.0038  $\Omega$ , 26 A, SO-8  
STripFET™ VI DeepGATE™ Power MOSFET

## Features

| Type        | V <sub>DSS</sub> | R <sub>DS(on)</sub><br>max | I <sub>D</sub> |
|-------------|------------------|----------------------------|----------------|
| STS26N3LLH6 | 30 V             | 0.0044 $\Omega$            | 26 A           |

- R<sub>DS(on)</sub> \* Q<sub>g</sub> industry benchmark
- Extremely low on-resistance R<sub>DS(on)</sub>
- High avalanche ruggedness
- Low gate drive power losses
- Very low switching gate charge

## Applications

- Switching applications

## Description

This product utilizes the 6th generation of design rules of ST's proprietary STripFET™ technology, with a new gate structure. The resulting Power MOSFET exhibits the lowest R<sub>DS(on)</sub> in all packages.

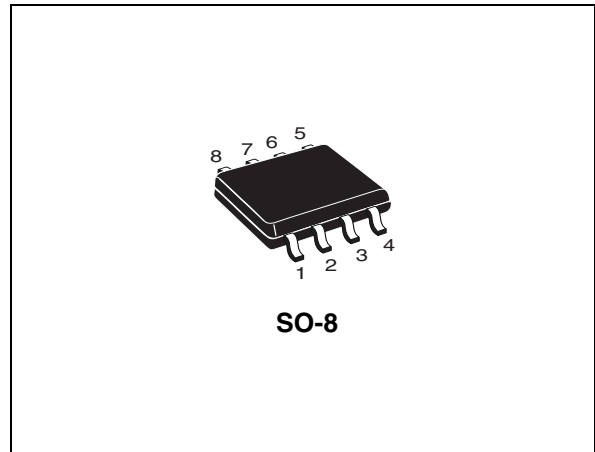


Figure 1. Internal schematic diagram

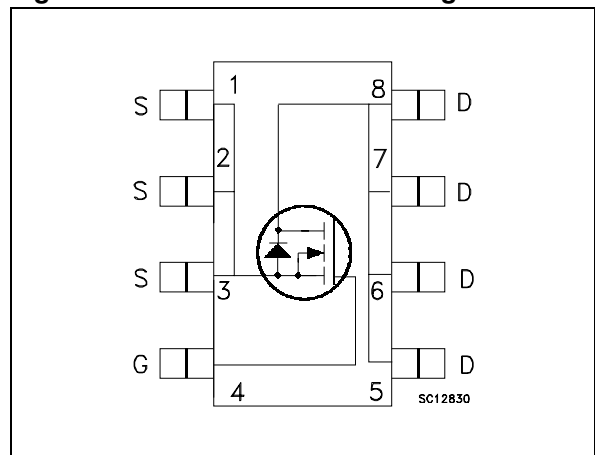


Table 1. Device summary

| Order code  | Marking | Packag | Packaging     |
|-------------|---------|--------|---------------|
| STS26N3LLH6 | 26G3L   | SO-8   | Tape and reel |

# Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

| Symbol             | Parameter   | Value      | Unit             |
|--------------------|---|------------|------------------|
| $V_{DS}$           | Drain-source voltage ( $V_{GS} = 0$ )                           | 30         | V                |
| $V_{GS}^{(1)}$     | Gate-source voltage   | $\pm 20$   | V                |
| $I_D$              | Drain current (continuous) at $T_C = 25\text{ }^\circ\text{C}$  | 26         | A                |
| $I_D$              | Drain current (continuous) at $T_C = 100\text{ }^\circ\text{C}$ | 16.25      | A                |
| $I_{DM}^{(2)}$     | Drain current (pulsed)  | 104        | A                |
| $P_{TOT}$          | Total dissipation at $T_{amb} = 25\text{ }^\circ\text{C}$       | 2.7        | W                |
| $T_J$<br>$T_{stg}$ | Operating junction temperature<br>Storage temperature           | -55 to 150 | $^\circ\text{C}$ |

1. Continuous mode
2. Pulse width limited by safe operating area

**Table 3. Thermal resistance**

| Symbol              | Parameter                           | Value | Unit               |
|---------------------|-------------------------------------|-------|--------------------|
| $R_{thj-amb}^{(1)}$ | Thermal resistance junction-ambient | 47    | $^\circ\text{C/W}$ |

1. When mounted on FR-4 board of 1inch<sup>2</sup>, 2oz Cu,  $t < 10$  sec

**Table 4. Avalanche data**

| Symbol   | Parameter  | Value | Unit |
|----------|--|-------|------|
| $I_{AV}$ | Not-repetitive avalanche current   | 40    | A    |
| $E_{AS}$ | Single pulse avalanche energy<br>(starting $T_j = 25\text{ }^\circ\text{C}$ , $I_D = I_{AV}$ ) | 525   | mJ   |

## 2 Electrical characteristics

( $T_{CASE} = 25\text{ °C}$  unless otherwise specified)

**Table 5. On/off states**

| Symbol        | Parameter  | Test conditions   | Min. | Typ.             | Max.             | Unit                 |
|---------------|--|---|------|------------------|------------------|----------------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage ( $V_{GS} = 0$ )  | $I_D = 250\ \mu A$  | 30   |                  |                  | V                    |
| $I_{DSS}$     | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = 30\text{ V}$<br>$V_{DS} = 30\text{ V}, T_C = 125\text{ °C}$                   |      |                  | 1<br>10          | $\mu A$<br>$\mu A$   |
| $I_{GSS}$     | Gate body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20\text{ V}$  |      |                  | $\pm 100$        | nA                   |
| $V_{GS(th)}$  | Gate threshold voltage                           | $V_{DS} = V_{GS}, I_D = 250\ \mu A$   | 1    |                  |                  | V                    |
| $R_{DS(on)}$  | Static drain-source on resistance                | $V_{GS} = 10\text{ V}, I_D = 13\text{ A}$<br>$V_{GS} = 4.5\text{ V}, I_D = 13\text{ A}$ |      | 0.0038<br>0.0047 | 0.0044<br>0.0053 | $\Omega$<br>$\Omega$ |

**Table 6. Dynamic**

| Symbol    | Parameter                    | Test conditions  | Min. | Typ. | Max. | Unit     |
|-----------|------------------------------|--|------|------|------|----------|
| $C_{ISS}$ | Input capacitance            | $V_{DS} = 25\text{ V}, f = 1\text{ MHz},$<br>$V_{GS} = 0$                                | -    | 4040 | -    | pF       |
| $C_{OSS}$ | Output capacitance           |  |      | 740  |      |          |
| $C_{RSS}$ | Reverse transfer capacitance |  |      | 425  |      |          |
| $Q_g$     | Total gate charge            | $V_{DD} = 15\text{ V}, I_D = 26\text{ A}$<br>$V_{GS} = 4.5\text{ V}$<br><i>Figure 19</i> | -    | 40   | -    | nC       |
| $Q_{gs}$  | Gate-source charge           |  |      | 13   |      | nC       |
| $Q_{gd}$  | Gate-drain charge            |  |      | 16   |      | nC       |
| $R_G$     | Gate input resistance        | f=1 MHz Gate DC Bias = 0<br>Test signal level = 20 mV open drain                         | -    | 1.4  | -    | $\Omega$ |

**Table 7. Switching times**

| Symbol       | Parameter           | Test conditions   | Min. | Typ. | Max. | Unit |    |
|--------------|---------------------|---|------|------|------|------|----|
| $t_{d(on)}$  | Turn-on delay time  | $V_{DD}=15\text{ V}$ , $I_D=13\text{ A}$ ,<br>$R_G=4.7\ \Omega$ , $V_{GS}=4.5\text{ V}$<br><i>Figure 13</i> |      | 17   |      | ns   |    |
| $t_r$        | Rise time           |   |      | 18   |      | ns   |    |
| $t_{d(off)}$ | Turn-off delay time |   |      | -    | 75   | -    | ns |
| $t_f$        | Fall time           |   |      |      | 46   |      | ns |

**Table 8. Source drain diode**

| Symbol          | Parameter                     | Test conditions  | Min | Typ. | Max | Unit |    |
|-----------------|-------------------------------|--|-----|------|-----|------|----|
| $I_{SD}$        | Source-drain current          |  | -   |      | 26  | A    |    |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |  | -   |      | 104 | A    |    |
| $V_{SD}^{(2)}$  | Forward on Voltage            | $I_{SD}=13\text{ A}$ , $V_{GS}=0$  | -   |      | 1.1 | V    |    |
| $t_{rr}$        | Reverse recovery time         | $I_{SD}=13\text{ A}$ ,<br>$di/dt = 100\text{ A}/\mu\text{s}$ ,<br>$V_{DD}=20\text{ V}$ , $T_j=150\text{ }^\circ\text{C}$<br><i>Figure 15</i> |     | 34   |     | ns   |    |
| $Q_{rr}$        | Reverse recovery charge       |  |     | -    | 35  |      | nC |
| $I_{RRM}$       | Reverse recovery current      |  |     |      | 2.1 |      | A  |

1. Pulse width limited by safe operating area
2. Pulsed: pulse duration=300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

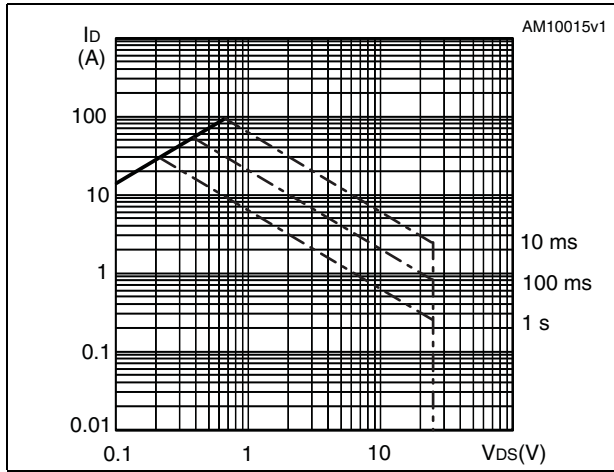


Figure 3. Thermal impedance

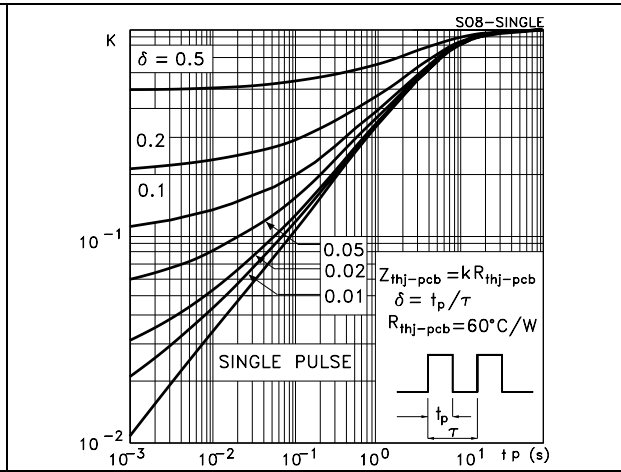


Figure 4. Output characteristics

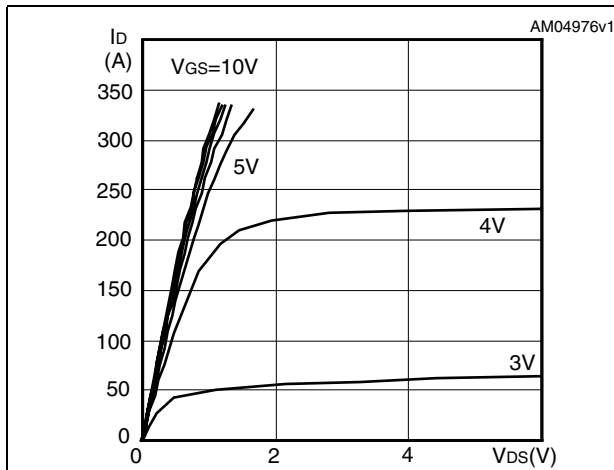


Figure 5. Transfer characteristics

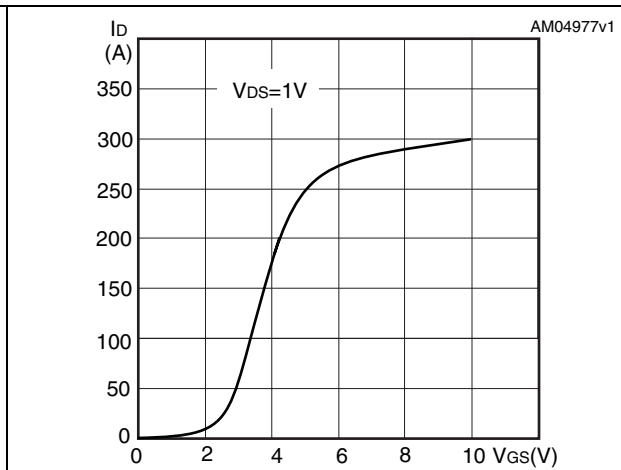


Figure 6. Normalized  $BV_{DSS}$  vs temperature

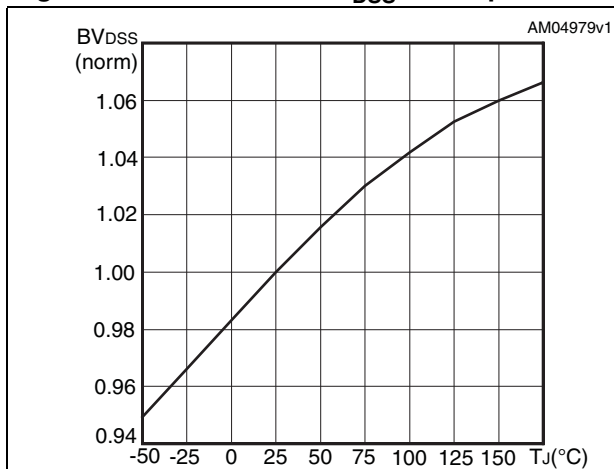


Figure 7. Static drain-source on resistance

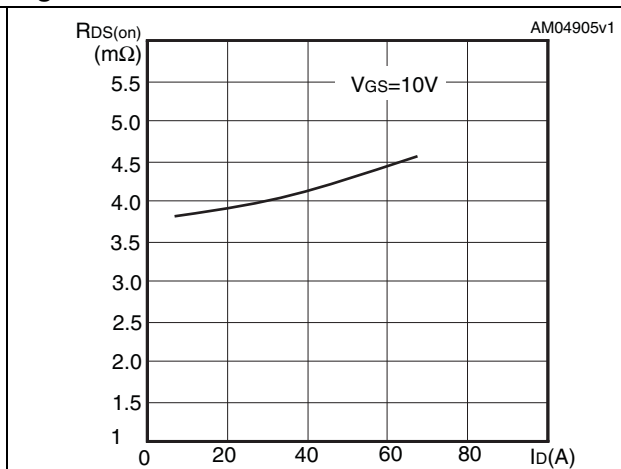


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

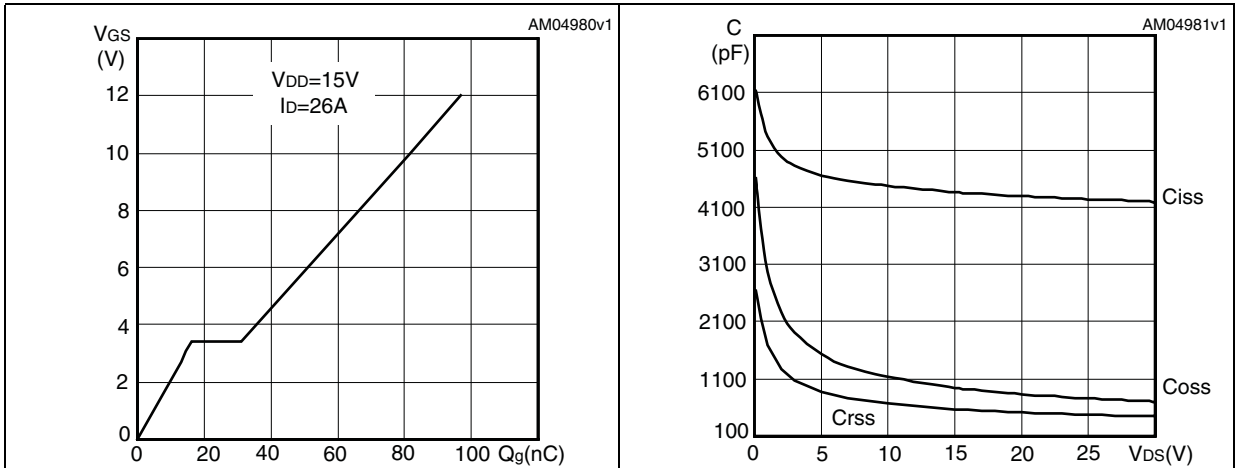


Figure 10. Normalized gate threshold voltage vs temperature Figure 11. Normalized on resistance vs temperature

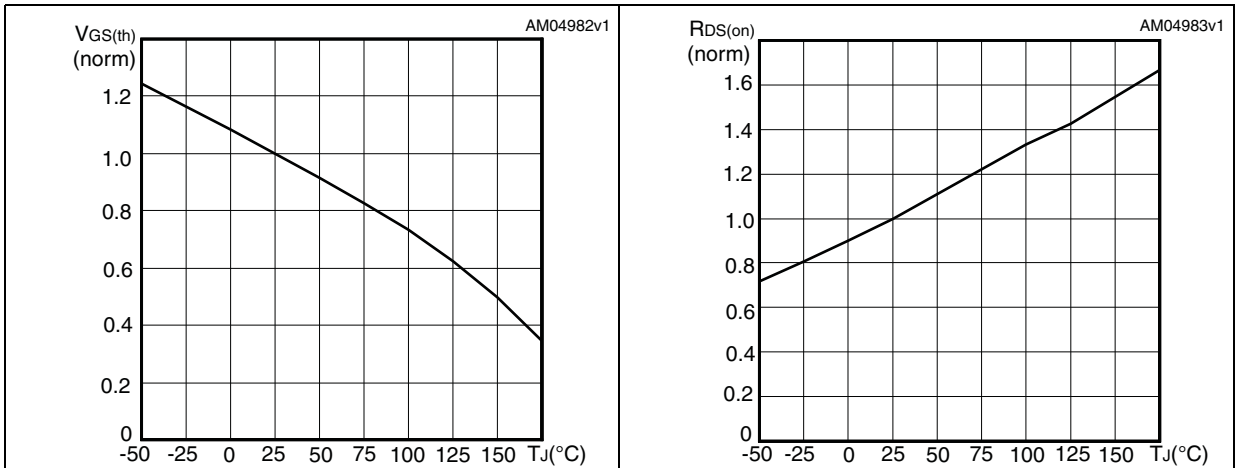
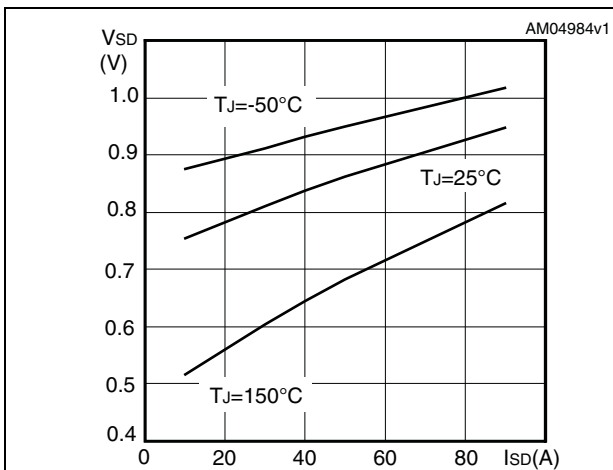
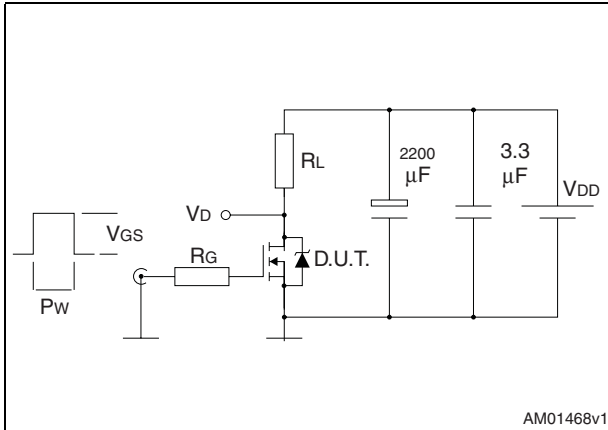


Figure 12. Source-drain diode forward characteristics



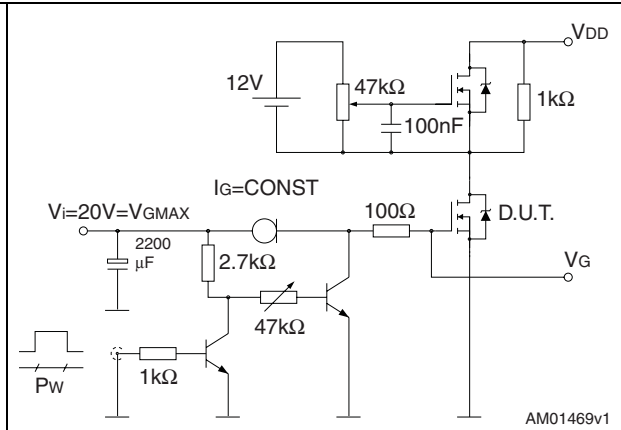
### 3 Test circuits

**Figure 13. Switching times test circuit for resistive load**



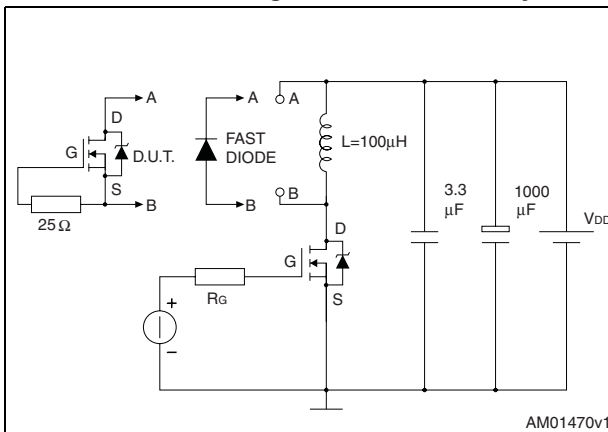
AM01468v1

**Figure 14. Gate charge test circuit**



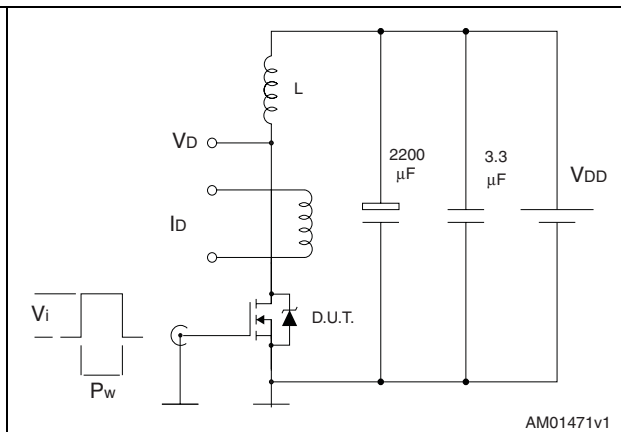
AM01469v1

**Figure 15. Test circuit for inductive load switching and diode recovery times**



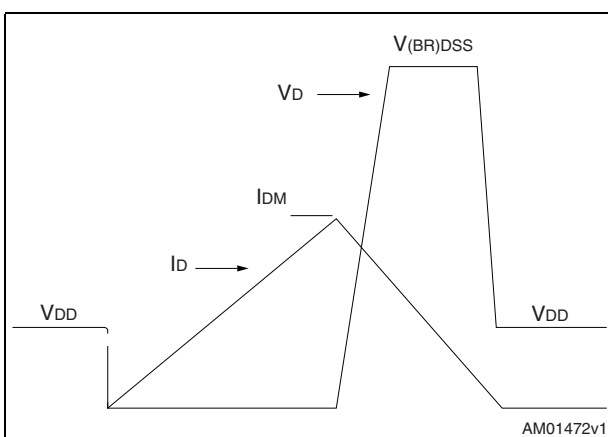
AM01470v1

**Figure 16. Unclamped inductive load test circuit**



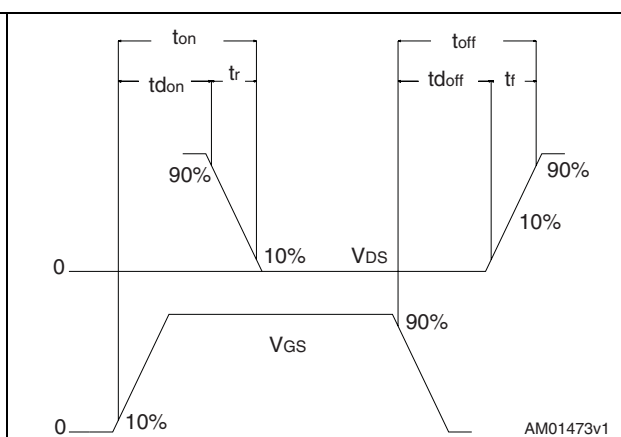
AM01471v1

**Figure 17. Unclamped inductive waveform**



AM01472v1

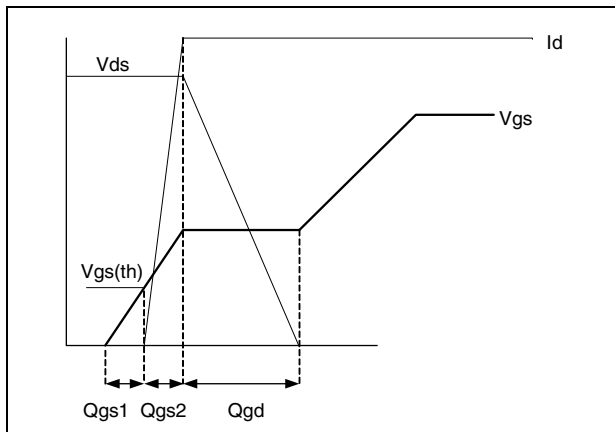
**Figure 18. Switching time waveform**



AM01473v1



Figure 19. Gate charge waveform



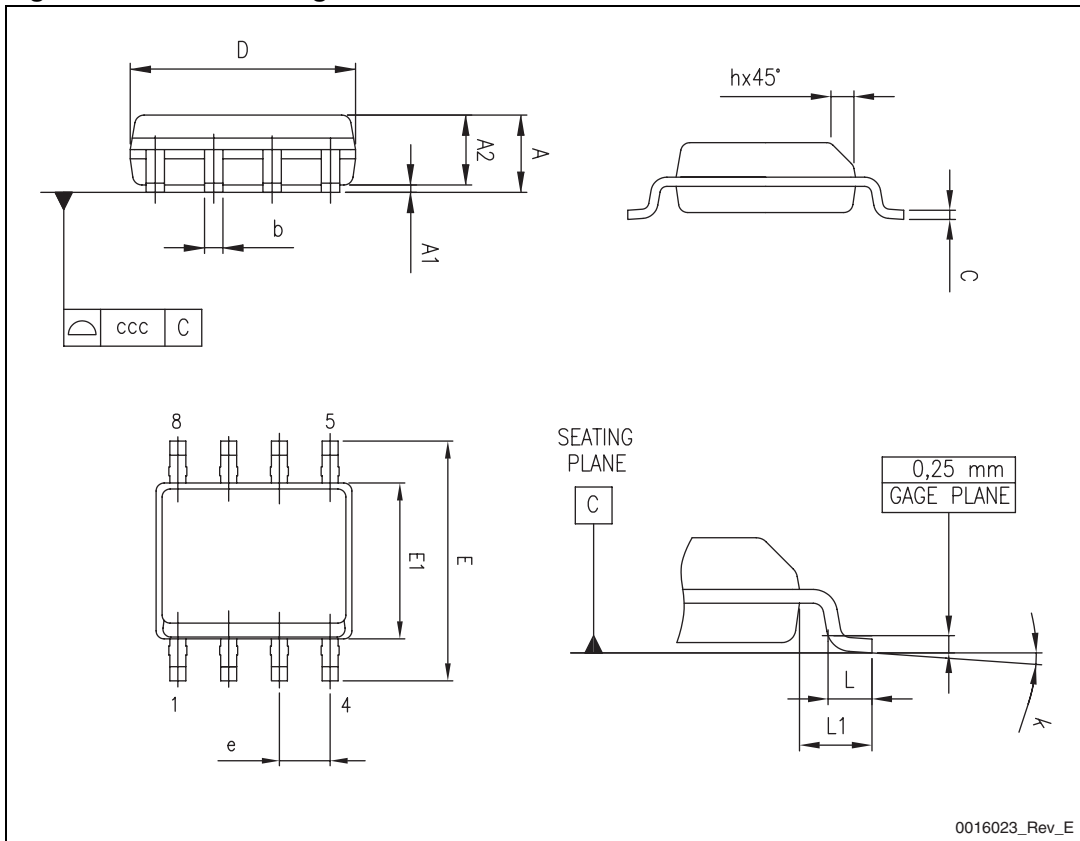
## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: [www.st.com](http://www.st.com). ECOPACK is an ST trademark.

Table 9. SO-8 mechanical data

| Dim. | mm   |      |      |
|------|------|------|------|
|      | Min. | Typ. | Max. |
| A    |      |      | 1.75 |
| A1   | 0.10 |      | 0.25 |
| A2   | 1.25 |      |      |
| b    | 0.28 |      | 0.48 |
| c    | 0.17 |      | 0.23 |
| D    | 4.80 | 4.90 | 5.00 |
| E    | 5.80 | 6.00 | 6.20 |
| E1   | 3.80 | 3.90 | 4.00 |
| e    |      | 1.27 |      |
| h    | 0.25 |      | 0.50 |
| L    | 0.40 |      | 1.27 |
| L1   |      | 1.04 |      |
| k    | 0°   |      | 8°   |
| ccc  |      |      | 0.10 |

Figure 20. SO-8 drawing



## 5 Revision history

**Table 10. Document revision history**

| Date        | Revision | Changes  |
|-------------|----------|--|
| 08-Jul-2011 | 1        | First release.   |
| 19-Oct-2011 | 2        | Document status promoted from preliminary data to datasheet. |

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